## nexperia

## **Quarterly Reliability Monitoring Results**

Quarters: Q1/2022 to Q4/2023

Based on structural similarity

| Supplier                                                         |                             | User Part Number                                     |             |                 |           |           |            |                          |
|------------------------------------------------------------------|-----------------------------|------------------------------------------------------|-------------|-----------------|-----------|-----------|------------|--------------------------|
| Nexperia B.V.<br>Name of Laboratory<br>Assembly reliability labs |                             | PESD3V3S1BSF Part Description                        |             |                 |           |           |            |                          |
|                                                                  |                             |                                                      |             |                 |           |           |            | NXP ICN8 Protection INDI |
|                                                                  |                             | BD package                                           |             |                 |           |           |            |                          |
|                                                                  |                             | Test                                                 |             | Test Conditions | Duration  | # Lots    | # Quantity | # Rejects                |
|                                                                  | TEST                        |                                                      |             |                 |           |           |            |                          |
|                                                                  | Pre- and Post-Stress        |                                                      |             |                 |           |           |            |                          |
| # 1                                                              | Electrical Test             | Tamb = 25 °C                                         | N/A         | see below       | all parts | see below |            |                          |
|                                                                  |                             | MIL-STD-750-1                                        |             |                 |           |           |            |                          |
|                                                                  | HTRB                        | M1038 Method A                                       |             |                 |           |           |            |                          |
|                                                                  | High Temperature Reverse    | Tj = Tjmax, Vr = 100% of max. datasheet              |             |                 |           |           |            |                          |
| # 5                                                              | Bias                        | reverse voltage                                      | 1000 hours  | 92              | 4040      | 0         |            |                          |
|                                                                  |                             |                                                      |             |                 |           |           |            |                          |
|                                                                  | тс                          | JESD22-A104                                          |             |                 |           |           |            |                          |
| # 7                                                              | Temperature Cycling         | -40 °C to 125°C                                      | 1000 cycles | 157             | 6880      | 0         |            |                          |
|                                                                  |                             |                                                      |             |                 |           |           |            |                          |
|                                                                  | UHAST                       | JESD22-A118                                          |             |                 |           |           |            |                          |
| # 8 <b>or</b>                                                    | Unbiased HAST               | Tamb = 130 °C, RH = 85 %                             | 0.5.1       |                 |           |           |            |                          |
|                                                                  |                             | JESD22-A102                                          | — 96 hours  | n.a.            | n.a.      | n.a.      |            |                          |
|                                                                  | AC                          | Tamb = 121 °C, RH = 100 %                            |             |                 |           |           |            |                          |
| # 8a                                                             | Autoclave                   | Pressure = 205 kPa (29.7 psia)                       |             |                 |           |           |            |                          |
|                                                                  |                             |                                                      |             |                 |           |           |            |                          |
|                                                                  | HAST                        | JESD22-A110                                          |             |                 |           |           |            |                          |
|                                                                  | Highly Accelerated Stress   | Tamb = 130 °C, RH = 85%, VR = 80 % of                |             |                 |           |           |            |                          |
| # 9                                                              | Test                        | rated reverse voltage <sup>[1]</sup>                 | 1000 hours  | 156             | 6840      | 0         |            |                          |
|                                                                  |                             | MIL-STD-750 Method 1037                              |             |                 |           |           |            |                          |
|                                                                  | IOL                         | ton = toff, devices powered to insure $\Delta T_j$ = |             |                 |           |           |            |                          |
| # 10                                                             | Intermittent Operating Life | 100 °C for 15000 cycles                              | 1000 hours  | n.a.            | n.a.      | n.a.      |            |                          |
| -                                                                |                             |                                                      |             | -               | -         |           |            |                          |
|                                                                  | RSH                         | JESD22-A111                                          |             |                 |           |           |            |                          |
| # 20                                                             | Resistance to Solder Heat   |                                                      | 10 s        | n.a.            | n.a.      | n.a.      |            |                          |
|                                                                  | SD                          |                                                      |             |                 |           |           |            |                          |
| # 21                                                             | Solderability               | J-STD-002                                            |             | 8               | 240       | 0         |            |                          |

[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

## Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test # 5) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

| NXP ICN8 Protection INDI 4040 0 1 1 951E+00 | Wafer Fab | Technology      | Quantity | Rejects | Failure Rate (FIT) | MTTF (hrs) |
|---------------------------------------------|-----------|-----------------|----------|---------|--------------------|------------|
| ······································      | NXP ICN8  | Protection INDI | 4040     | 0       | 1,1                | 9,51E+08   |

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